

CCB032M12FM3, CCB032M12FM3T

 $\begin{array}{ll} \text{V}_{\text{DS}} & \text{1200 V} \\ \text{R}_{\text{DS(on)}} & \text{32 m}\Omega \end{array}$

1200 V, 32 m Ω , Silicon Carbide, Six-Pack Module

Technical Features

- Ultra-Low Loss
- High Frequency Operation
- Zero Turn-Off Tail Current from MOSFET
- Normally-Off, Fail-Safe Device Operation
- Optional Pre-Applied Thermal Interface Material



Applications

- DC-DC Converters
- EV Chargers
- High-Efficiency Converters / Inverters
- Renewable Energy
- Smart-Grid / Grid-Tied Distributed Generation

System Benefits

- Enables Compact, Lightweight Systems
- Increased System Efficiency, due to Low Switching & Conduction Losses of SiC
- Reduced Thermal Requirements and System Cost

Maximum Parameters (Verified by Design)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Test Conditions | Note | |
|--|-------------------------|------|------|------|------|--|---------|--|
| Drain-Source Voltage | V _{DS} | | | 1200 | | | | |
| Gate-Source Voltage, Maximum Value | V _{GS max} | -8 | | +19 | V | Transient, < 100 ns | Fig. 33 | |
| Gate-Source Voltage, Recommended | V _{GS op} | -4 | | +15 | | Static | | |
| DC Continuous Drain Current (T _{VJ} ≤ 150 °C) | | | | 30 | | $V_{GS} = 15 \text{ V}, \ T_{HS} = 50 ^{\circ}\text{C}, \ T_{VJ} \leq 150 ^{\circ}\text{C}$ | Fig. 20 | |
| DC Continuous Drain Current (T _{VJ} ≤ 175 °C) | I _D | | | 30 | | $V_{GS} = 15 \text{ V}, \ T_{HS} = 50 \text{ °C}, \ T_{VJ} \le 175 \text{ °C}$ | | |
| DC Source-Drain Current (Body Diode) | I _{SD BD} | | 27 | | Α | $V_{GS} = -4 \text{ V}, \ T_{HS} = 50 \text{ °C}, T_{VJ} \le 175 \text{ °C}$ | | |
| Pulsed Drain Current | I _{D (pulsed)} | | | 60 | | t _{Pmax} limited by T _{VJmax} V _{GS} = 15 V, T _{HS} = 50 °C | | |
| Virtual Junction Temperature | T _{VJ op} | -40 | | 150 | °C | Operation | | |
| | | -40 | | 175 | | Intermittent with Reduced Life | | |

MOSFET Characteristics (Per Position) ($T_{yJ} = 25$ °C unless otherwise specified)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Test Conditions | Note | |
|---|----------------------|------|-------------------------|------|------|--|--------------------|--|
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | 1200 | | | | V _{GS} = 0 V, T _{VJ} = -40 °C | | |
| | V _{GS(th)} | 1.8 | 2.5 | 3.6 | V | $V_{DS} = V_{GS}, I_{D} = 11.5 \text{ mA}$ | | |
| Gate Threshold Voltage | | | 2.0 | | | $V_{DS} = V_{GS}$, $I_D = 11.5$ mA, $T_{VJ} = 150$ °C | | |
| Zero Gate Voltage Drain Current | I _{DSS} | | 1 | 19 | μΑ | V _{GS} = 0 V, V _{DS} = 1200 V | | |
| Gate-Source Leakage Current | I _{GSS} | | 10 | 250 | nA | V _{GS} = 15 V, V _{DS} = 0 V | | |
| | | | 32.0 | 42.6 | | $V_{GS} = 15 \text{ V}, I_{D} = 30 \text{ A}$ | Fig. 2 Fig. 3 | |
| Drain-Source On-State Resistance (Devices Only) | R _{DS(on)} | | 51.2 | | mΩ | V _{GS} = 15 V, I _D = 30 A, T _{VJ} = 150 °C | | |
| (201000 011) | | | 57.6 | | | V _{GS} = 15 V, I _D = 30 A, T _{VJ} = 175 °C | | |
| Transconductance | g fs | | 21.3 | | | $V_{DS} = 20 \text{ V}, I_{D} = 30 \text{ A}$ | Fig. 4 | |
| | | | 20.1 | | - S | V _{DS} = 20 V, I _D = 30 A, T _{VJ} = 150 °C | | |
| Turn-On Switching Energy, T_{VJ} = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C | Eon | | 0.41 0.80 0.95 | | | $V_{DD} = 600 \text{ V},$ $I_{D} = 30 \text{ A},$ | Fig. 11 Fig. 13 | |
| Turn-Off Switching Energy, T_{VJ} = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C | E _{off} | | 0.005 0.006 0.007 | | mJ | $\begin{aligned} &V_{\text{GS}} = -4 \text{ V/15 V,} \\ &R_{\text{G(OFF)}} = 1.0 \Omega, R_{\text{G(ON)}} = 1.0 \Omega, \\ &L = 45.1 \mu\text{H} \end{aligned}$ | | |
| Internal Gate Resistance | R _{G(int)} | | 1.7 | | Ω | f = 100 kHz, V _{AC} = 25 mV | | |
| Input Capacitance | C _{iss} | | 3.4 | | nF | | Fig. 9 | |
| Output Capacitance | C _{oss} | | 144 | | | $V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V},$ $V_{AC} = 25 \text{ mV}, f = 100 \text{ kHz}$ | | |
| Reverse Transfer Capacitance | C _{rss} | | 14 | | pF | V _{AC} – 25 IIIV, I – 100 KHZ | | |
| Gate to Source Charge | Q _{GS} | | 40 | | | V _{DS} = 800 V, V _{GS} = -4 V/15 V, | | |
| Gate to Drain Charge | Q_{GD} | | 34 | | nC | $I_D = 40 \text{ A},$ | | |
| Total Gate Charge | Q _G | | 118 | | | Per IEC60747-8-4 pg 21 | | |
| FET Thermal Resistance, Junction to Heatsink | R _{th JHS} | | 1.205 | | °C/W | Measured with Pre-Applied TIM | Fig. 17 | |

Diode Characteristics (Per Position) (T_{VJ} = 25 °C unless otherwise specified)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Test Conditions | Notes |
|---|------------------|------|----------------------|------|------|--|---------|
| Body Diode Forward Voltage | V_{SD} | | 4.6 | | V | $V_{GS} = -4 \text{ V}, I_{SD} = 30 \text{ A}$ | Fig. 7 |
| | | | 4.4 | | | $V_{GS} = -4 \text{ V}, I_{SD} = 30 \text{ A}, T_{VJ} = 150 ^{\circ}\text{C}$ | Fig. 7 |
| Reverse Recovery Time | t _{RR} | | 17 | | ns | | |
| Reverse Recovery Charge | Q_{RR} | | 1.20 | | μС | $V_{GS} = -4 \text{ V}, I_{SD} = 30 \text{ A}, V_{R} = 600 \text{ V},$ $di/dt = 15.0 \text{ A/ns}, T_{VJ} = 150 ^{\circ}\text{C}$ | Fig. 32 |
| Peak Reverse Recovery Current | I _{RRM} | | 115 | | А | - di/dt 15.07(115, T() 150 C | |
| Reverse Recovery Energy, T_{VJ} = 25 °C T_{VJ} = 125 °C T_{VJ} = 150 °C | E _{RR} | | 0.13 0.26 0.31 | | mJ | $V_{DD} = 600 \text{ V}, \ I_D = 30 \text{ A}, \ V_{GS} = -4 \text{ V}/15 \text{ V}, \ R_{G(ON)} = 1.0 \ \Omega, \ L = 45.1 \ \mu\text{H}$ | Fig. 14 |

Module Physical Characteristics

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Test Conditions |
|------------------------------------|--------------------|------|------|------|------|---|
| Package Resistance, M1 (High-Side) | R _{HS} | | 5.90 | | 0 | $T_c = 125$ °C, $I_D = 30$ A, Note 1 |
| Package Resistance, M2 (Low-Side) | R _{LS} | | 8.10 | | mΩ | T _C = 125°C, I _D = 30 A, Note 1 |
| Stray Inductance | L _{Stray} | | 17.4 | | nΗ | Between DC- and DC+, f = 10 MHz |
| Case Temperature | T _c | -40 | | 125 | °C | |
| Mounting Torque | Ms | | 2.0 | 2.3 | N-m | M4 bolts |
| Weight | W | | 21 | | g | |
| Case Isolation Voltage | V _{isol} | 3 | | | kV | AC, 50 Hz, 1 minute |
| Comparative Tracking Index | СТІ | 200 | | | | |
| Clearance Distance | | | 5.0 | | | Terminal to Terminal |
| | | | 10.0 | | | Terminal to Heatsink |
| Creepage Distance | | | 6.3 | | mm | Terminal to Terminal |
| | | | 11.5 | | | Terminal to Heatsink |

Motas.

NTC Thermistor Characterization

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Test Conditions |
|--------------------------------------|---------------------|------|------|------|------|-------------------------|
| Rated Resistance | R _{NTC} | | 5.0 | | kΩ | T _{NTC} = 25°C |
| Resistance Tolerance at 25 °C | ΔR/R | -5 | | 5 | % | |
| Beta Value (T ₂ = 50 °C) | β _{25/50} | | 3380 | | K | |
| Beta Value (T ₂ = 80 °C) | β _{25/80} | | 3468 | | K | |
| Beta Value (T ₂ = 100 °C) | β _{25/100} | | 3523 | | K | |
| Power Dissipation | P _{Max} | | | 10 | mW | T _{NTC} = 25°C |

¹Total Effective Resistance (Per Switch Position) = MOSFET R_{DS(on)} + Switch Position Package Resistance

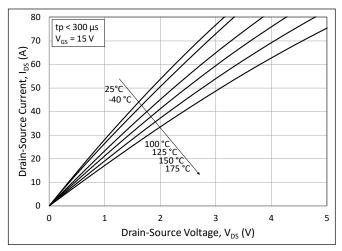


Figure 1. Output Characteristics for Various Junction Temperatures

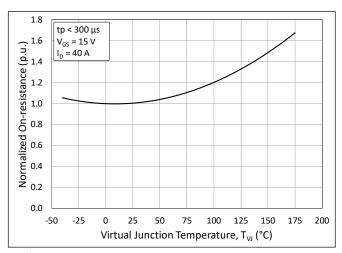


Figure 3. Normalized On-State Resistance vs. Junction Temperature

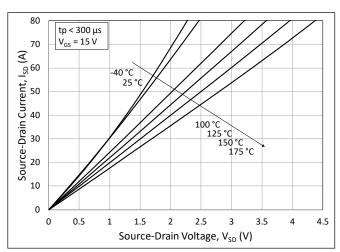


Figure 5. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = 15 \text{ V}$

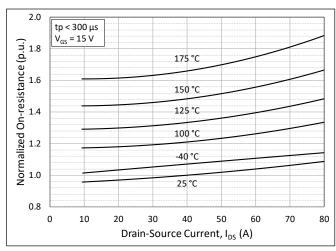


Figure 2. Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures

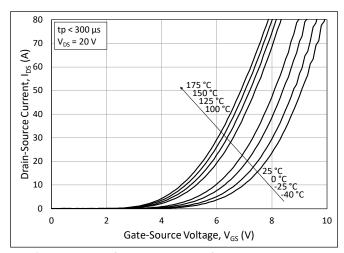


Figure 4. Transfer Characteristic for Various Junction Temperatures

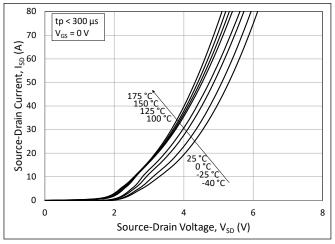


Figure 6. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = 0 \text{ V}$

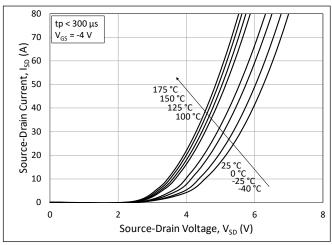


Figure 7. 3^{rd} Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = -4 \text{ V (Body Diode)}$

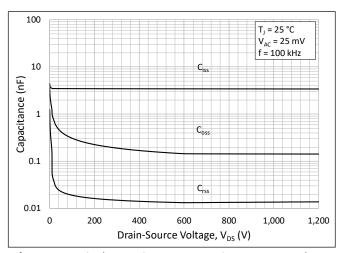


Figure 9. Typical Capacitances vs. Drain to Source Voltage (0 - 1200 V)

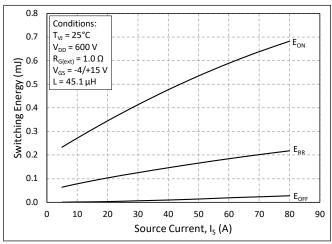


Figure 11. Switching Energy vs. Drain Current (V_{DD} = 600 V)

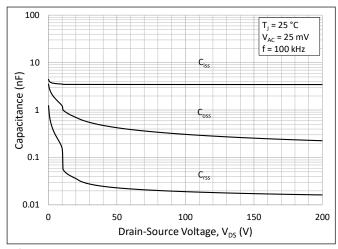


Figure 8. Typical Capacitances vs. Drain to Source Voltage (0 - 200 V)

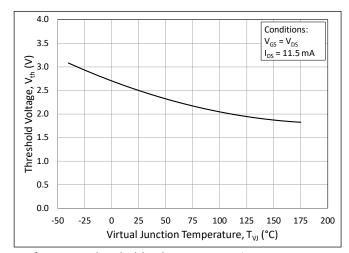


Figure 10. Threshold Voltage vs. Junction Temperature

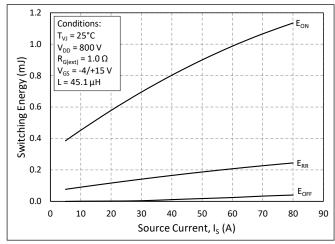


Figure 12. Switching Energy vs. Drain Current (V_{DD} = 800 V)

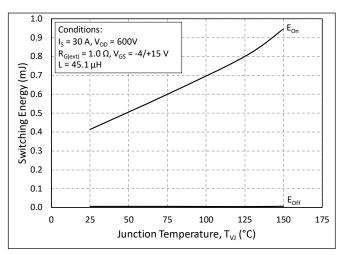


Figure 13. MOSFET Switching Energy vs. Junction Temperature

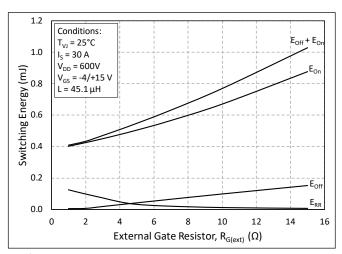


Figure 15. MOSFET Switching Energy vs. External Gate Resistance

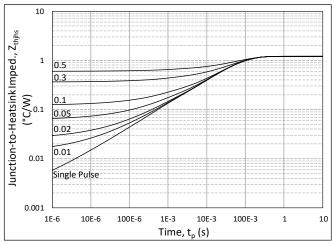


Figure 17. MOSFET Junction to Heatsink Transient Thermal Impedance, $Z_{th\,JHS}$ (°C/W)

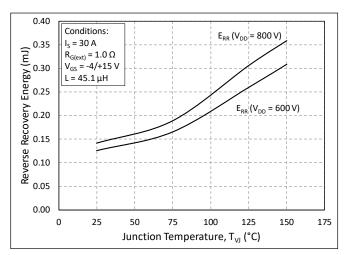


Figure 14. Reverse Recovery Energy vs. Junction Temperature

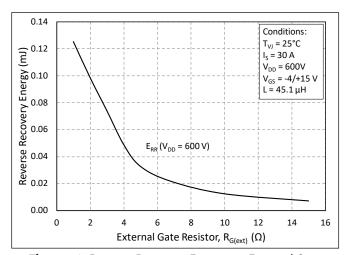


Figure 16. Reverse Recovery Energy vs. External Gate Resistance

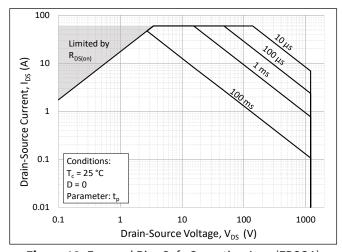


Figure 18. Forward Bias Safe Operating Area (FBSOA)

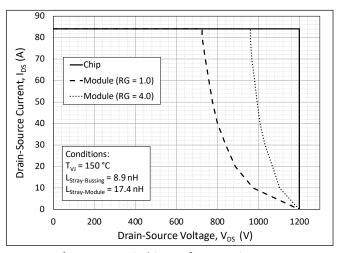


Figure 19. Switching Safe Operating Area

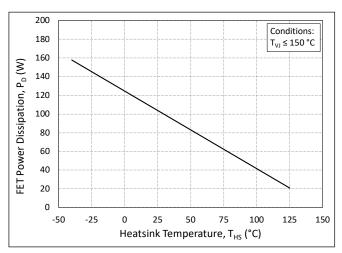


Figure 21. Maximum Power Dissipation Derating vs. Heatsink Temperature

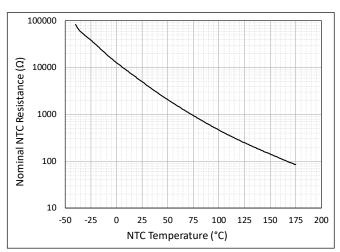


Figure 23. Nominal NTC Resistance vs. NTC Temperature

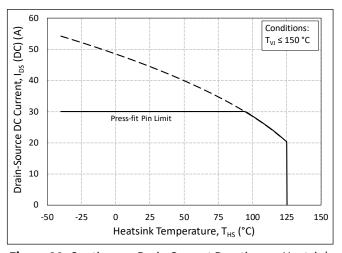


Figure 20. Continuous Drain Current Derating vs. Heatsink Temperature

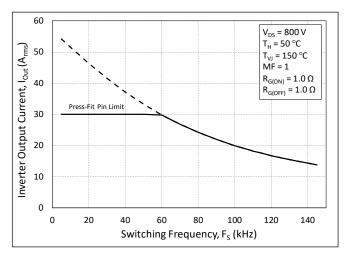


Figure 22. Typical Output Current Capability vs. Switching Frequency (Inverter Application)

Timing Characteristics

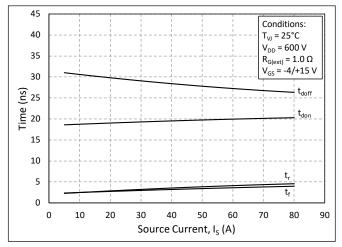


Figure 24. Timing vs. Source Current

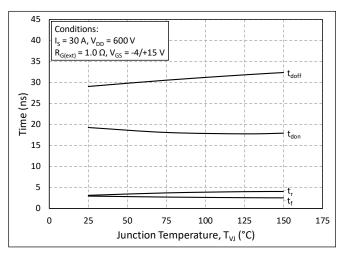


Figure 26. Timing vs. Junction Temperature

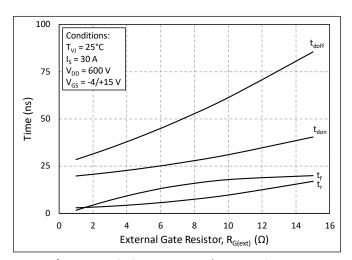


Figure 28. Timing vs. External Gate Resistance

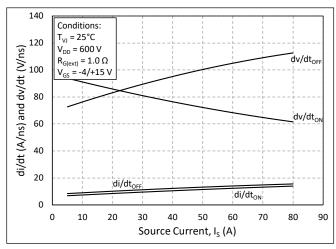


Figure 25. dv/dt and di/dt vs. Source Current

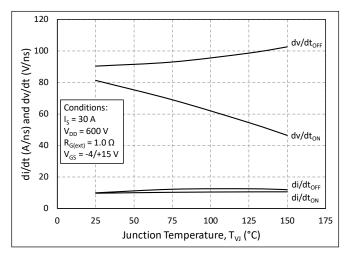


Figure 27. dv/dt and di/dt vs. Junction Temperature

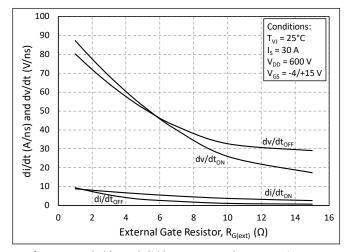


Figure 29. dv/dt and di/dt vs. External Gate Resistance

Definitions

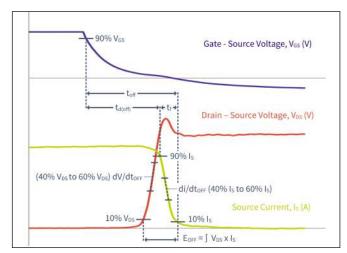


Figure 30. Turn-off Transient Definitions

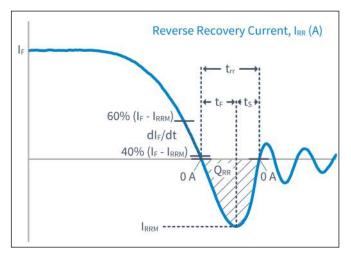


Figure 32. Reverse Recovery Definitions

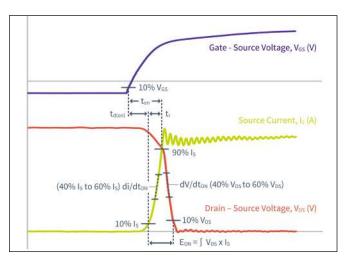


Figure 31. Turn-on Transient Definitions

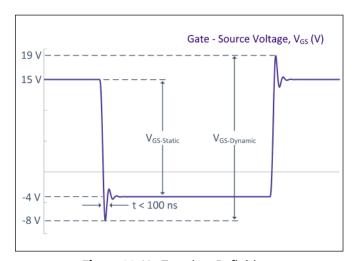
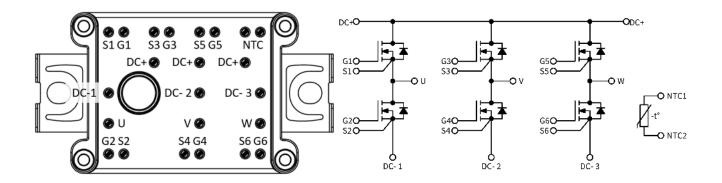
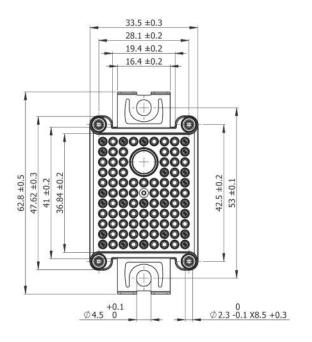


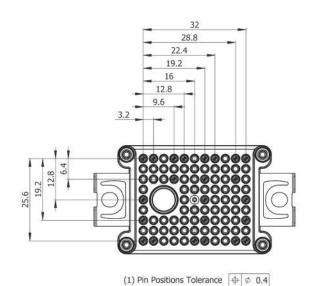
Figure 33. V_{GS} Transient Definitions

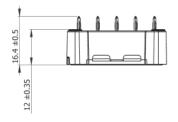
Pinout

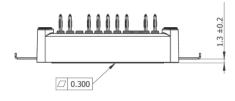


Package Dimension (mm)









Product Ordering Code

| Part Number | Description | | | |
|---------------|---|--|--|--|
| CCB032M12FM3 | Without Pre-Applied Phase Change Thermal Interface Material | | | |
| CCB032M12FM3T | With Pre-Applied Phase Change Thermal Interface Material | | | |

Supporting Links & Tools

Evaluation Tools & Support

- KIT-CRD-CIL12N-FMC: Dynamic Evaluation Board for Six-Pack FM3 Modules
- CCB032M12FM3 PLECS Model
- SpeedFit 2.0 Design Simulator™
- <u>Technical Support Forum</u>

Dual-Channel Gate Driver Board

- EVAL-ADUM4146WHB1Z: Analog Devices® Gate Driver Board
- Si823H-AxWA-KIT: Skyworks® Gate Driver Board
- ACPL-355JC: Broadcom® Gate Driver Board
- CGD1700HB2M-UNA: Wolfspeed Gate Driver Board
- CGD12HB00D: Differential Transceiver Daughter Board Companion Tool for Differential Gate Drivers

Application Notes

- CPWR-AN41: Mounting Instructions and PCB Requirements
- CPWR-AN42: Thermal Interface Material Application Note
- CPWR-AN45: Dynamic Performance Application Note

Notes & Disclaimer

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Contact info:

4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power